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Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/726,677	CHOO ET AL.	
Examiner	Art Unit	······································
James A. Dudek	2871	

SEARCHED				
Class	Subclass	Date	Examiner	
349	187,189, 190	4/26/2005	JAD	
UPdated		12/11/2006	JAD	
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